

## Features

- Temperature ranges
  - Commercial: 0°C to 70°C
  - Industrial/Automotive -A: -40°C to 85°C
  - Automotive-E: -40°C to 125°C
- High speed
  - $t_{AA} = 10 \text{ ns}$
- Low active power
  - 324 mW (max.)
- 2.0V data retention
- Automatic power down when deselected
- TTL-compatible inputs and outputs
- Easy memory expansion with  $\overline{CE}$  and  $\overline{OE}$  features

## Functional Description

The CY7C1049CV33 is a high performance CMOS Static RAM organized as 524,288 words by eight bits. Easy memory expansion is provided by an active LOW Chip Enable ( $\overline{CE}$ ), an active LOW Output Enable ( $\overline{OE}$ ), and three-state drivers. Writing to the device is accomplished by taking Chip Enable ( $\overline{CE}$ ) and Write Enable ( $\overline{WE}$ ) inputs LOW. Data on the eight I/O pins ( $I/O_0$  through  $I/O_7$ ) is then written into the location specified on the address pins ( $A_0$  through  $A_{18}$ ).

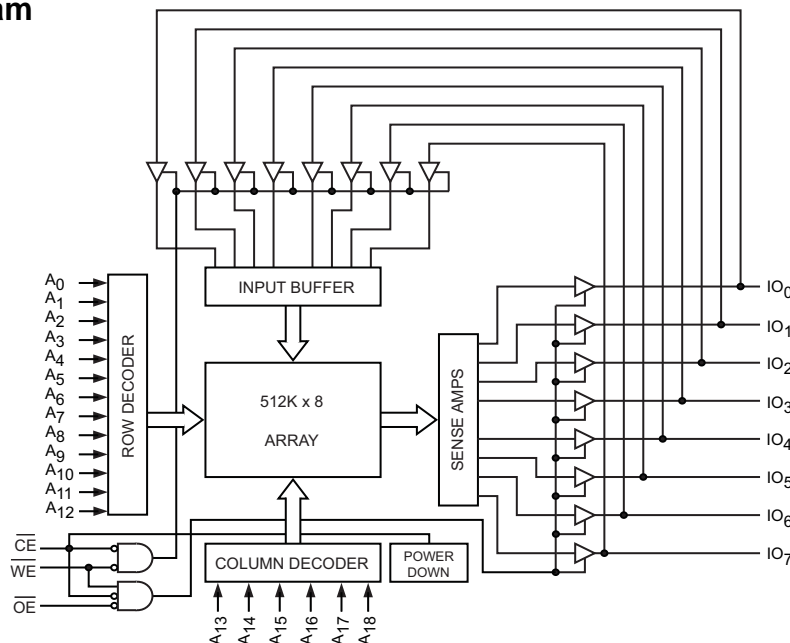
Reading from the device is accomplished by taking Chip Enable ( $\overline{CE}$ ) and Output Enable ( $\overline{OE}$ ) LOW while forcing Write Enable ( $\overline{WE}$ ) HIGH. Under these conditions, the contents of the memory location specified by the address pins will appear on the I/O pins.

The eight input and output pins ( $I/O_0$  through  $I/O_7$ ) are placed in a high impedance state when the device is deselected ( $\overline{CE}$  HIGH), the outputs are disabled ( $\overline{OE}$  HIGH), or during a write operation ( $\overline{CE}$  LOW, and  $\overline{WE}$  LOW).

The CY7C1049CV33 is available in standard 400-mil-wide 36-pin SOJ package and 44-pin TSOP II package with center power and ground (revolutionary) pinout.

For best practice recommendations, refer to the Cypress application note [AN1064, SRAM System Guidelines](#).

## Logic Block Diagram



## Pin Configuration

Figure 1. 36-Pin SOJ (Top View)

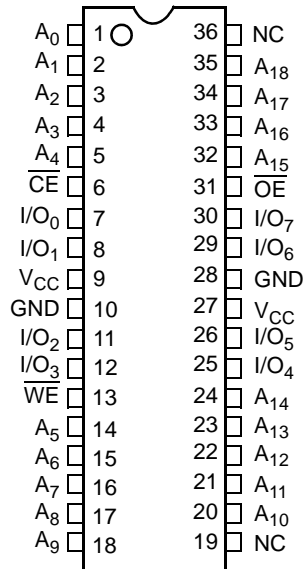
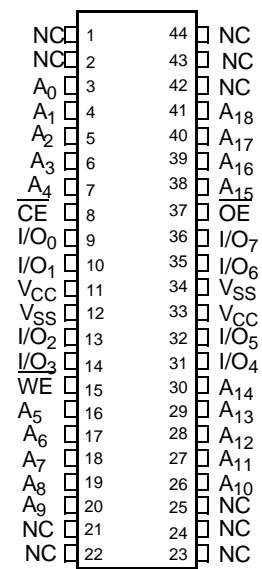


Figure 2. 44-Pin TSOP II (Top View)



## Selection Guide

Description		-10	-12	-15	Unit
Maximum Access Time		10	12	15	ns
Maximum Operating Current	Commercial	90	85	-	mA
	Industrial/Automotive-A	100	95	-	mA
	Automotive-E	-	-	95	mA
Maximum CMOS Standby Current	Commercial/Industrial/ Automotive-A	10	10	-	mA
	Automotive-E	-	-	15	mA

**Pin Definitions**

Pin Name	36-SOJ Pin Number	44 TSOP-II Pin Number	I/O Type	Description
A <sub>0</sub> –A <sub>18</sub>	1–5,14–18, 20–24,32–35	3–7,16–20, 26–30,38–41	Input	<b>Address inputs used to select one of the address locations.</b>
I/O <sub>0</sub> –I/O <sub>7</sub>	7,8,11,12,25, 26,29,30	9,10,13,14, 31,32,35,36	Input/Output	<b>Bidirectional data I/O lines.</b> Used as input or output lines depending on operation
NC <sup>[1]</sup>	19,36	1,2,21,22,23,24, 25,42,43, 44	No Connect	<b>No connects.</b> This pin is not connected to the die
$\overline{\text{WE}}$	13	15	Input/Control	<b>Write Enable input, active LOW.</b> When selected LOW, a WRITE is conducted. When selected HIGH, a READ is conducted.
$\overline{\text{CE}}$	6	8	Input/Control	<b>Chip Enable input, active LOW.</b> When LOW, selects the chip. When HIGH, deselects the chip.
$\overline{\text{OE}}$	31	37	Input/Control	<b>Output Enable, active LOW.</b> Controls the direction of the I/O pins. When LOW, the I/O pins are allowed to behave as outputs. When deasserted HIGH, I/O pins are three-stated, and act as input data pins.
V <sub>SS</sub> , GND	10,28	12,34	Ground	<b>Ground for the device.</b> Should be connected to ground of the system.
V <sub>CC</sub>	9,27	11,33	Power Supply	<b>Power supply inputs to the device.</b>

**Note**

1. NC pins are not connected on the die.

## Maximum Ratings

Exceeding maximum ratings may impair the useful life of the device. These user guidelines are not tested.

Storage Temperature ..... -65°C to +150°C

Ambient Temperature with  
Power Applied ..... -55°C to +125°C

Supply Voltage on  $V_{CC}$  to Relative GND<sup>[2]</sup> -0.5V to +4.6VDC

Voltage Applied to Outputs  
in High-Z State<sup>[2]</sup> ..... -0.5V to  $V_{CC} + 0.5V$

Input Voltage<sup>[2]</sup> ..... -0.5V to  $V_{CC} + 0.5V$

Current into Outputs (LOW) ..... 20 mA

## Operating Range

Range	Ambient Temperature	$V_{CC}$
Commercial	0°C to +70°C	3.3V ± 0.3V
Industrial/ Automotive-A	-40°C to +85°C	
Automotive-E	-40°C to +125°C	

## Electrical Characteristics

Over the Operating Range

Parameter	Description	Test Conditions	-10		-12		-15		Unit
			Min	Max	Min	Max	Min	Max	
$V_{OH}$	Output HIGH Voltage	$V_{CC} = \text{Min.}; I_{OH} = -4.0 \text{ mA}$	2.4		2.4		2.4		V
$V_{OL}$	Output LOW Voltage	$V_{CC} = \text{Min.}; I_{OL} = 8.0 \text{ mA}$		0.4		0.4		0.4	V
$V_{IH}$	Input HIGH Voltage		2.0	$V_{CC} + 0.3$	2.0	$V_{CC} + 0.3$	2.0	$V_{CC} + 0.3$	V
$V_{IL}$	Input LOW Voltage <sup>[2]</sup>		-0.3	0.8	-0.3	0.8	-0.3	0.8	V
$I_{IX}$	Input Load Current	$GND \leq V_I \leq V_{CC}$	Com'I/Ind'I/ Auto-A	-1	+1	-1	+1		$\mu\text{A}$
								-20 +20	
$I_{CC}$	$V_{CC}$ Operating Supply Current	$V_{CC} = \text{Max.},$ $f = f_{\text{MAX}} = 1/t_{RC}$	Com'I		90		85		mA
			Ind'I/Auto-A		100		95		
			Auto-E					95	
$I_{SB1}$	Automatic CE Power Down Current —TTL Inputs	Max. $V_{CC}$ , $CE \geq V_{IH}$ ; $V_{IN} \geq V_{IH}$ or $V_{IN} \leq V_{IL}$ , $f = f_{\text{MAX}}$	Com'I/Ind'I/ Auto-A		40		40		mA
			Auto-E					45	
$I_{SB2}$	Automatic CE Power Down Current —CMOS Inputs	Max. $V_{CC}$ , $CE \geq V_{CC} - 0.3V$ , $V_{IN} \geq V_{CC} - 0.3V$ , or $V_{IN} \leq 0.3V$ , $f = 0$	Com'I/Ind'I/ Auto-A		10		10		mA
			Auto-E					15	

## Capacitance

Tested initially and after any design or process changes that may affect these parameters.

Parameter	Description	Test Conditions	Max	Unit
$C_{IN}$	Input Capacitance	$T_A = 25^\circ\text{C}$ , $f = 1 \text{ MHz}$ , $V_{CC} = 3.3V$	8	pF
$C_{OUT}$	I/O Capacitance		8	pF

## Thermal Resistance

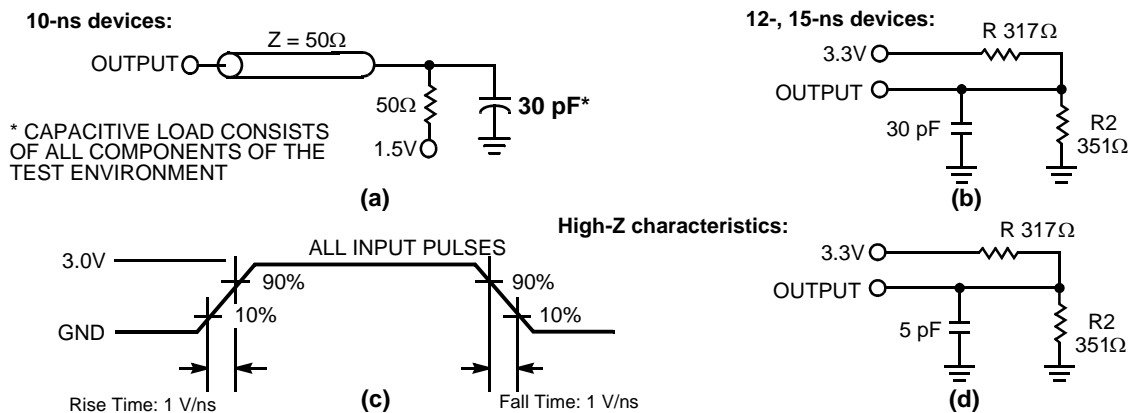
Tested initially and after any design or process changes that may affect these parameters.

Parameter	Description	Test Conditions	36-Pin SOJ	44-TSOP-II	Unit
$\Theta_{JA}$	Thermal Resistance (Junction to Ambient)	Test conditions follow standard test methods and procedures for measuring thermal impedance, per EIA / JESD51.	46.51	41.66	$^\circ\text{C/W}$
$\Theta_{JC}$	Thermal Resistance (Junction to Case)		18.8	10.56	$^\circ\text{C/W}$

### Notes

2.  $V_{IL}(\text{min}) = -2.0V$  and  $V_{IH}(\text{max}) = V_{CC} + 0.5V$  for pulse durations of less than 20 ns.

3. Tested initially and after any design or process changes that may affect these parameters.

**Figure 3. AC Test Loads and Waveforms [3]**

**Note**

4. AC characteristics (except High-Z) for 10-ns parts are tested using the load conditions shown in Figure (a). All other speeds are tested using the Thevenin load shown in Figure (b). High-Z characteristics are tested for all speeds using the test load shown in Figure (d).

## AC Switching Characteristics

Over the Operating Range <sup>[5]</sup>

Parameter	Description	-10		-12		-15		Unit
		Min	Max	Min	Max	Min	Max	
Read Cycle								
t <sub>power</sub> <sup>[6]</sup>	V <sub>CC</sub> (typical) to the first access	100		100		100		μs
t <sub>RC</sub>	Read Cycle Time	10		12		15		ns
t <sub>AA</sub>	Address to Data Valid		10		12		15	ns
t <sub>OHA</sub>	Data Hold from Address Change	3		3			3	ns
t <sub>ACE</sub>	$\overline{\text{CE}}$ LOW to Data Valid		10		12		15	ns
t <sub>DOE</sub>	$\overline{\text{OE}}$ LOW to Data Valid		5		6		7	ns
t <sub>LZOE</sub>	$\overline{\text{OE}}$ LOW to Low-Z	0		0		0		ns
t <sub>HZOE</sub>	$\overline{\text{OE}}$ HIGH to High-Z <sup>[7, 8]</sup>		5		6		7	ns
t <sub>LZCE</sub>	$\overline{\text{CE}}$ LOW to Low-Z <sup>[8]</sup>	3		3		3		ns
t <sub>HZCE</sub>	$\overline{\text{CE}}$ HIGH to High-Z <sup>[7, 8]</sup>		5		6		7	ns
t <sub>PU</sub>	$\overline{\text{CE}}$ LOW to Power Up	0		0		0		ns
t <sub>PD</sub>	$\overline{\text{CE}}$ HIGH to Power Down		10		12		15	ns
Write Cycle <sup>[9, 10]</sup>								
t <sub>WC</sub>	Write Cycle Time	10		12		15		ns
t <sub>SCE</sub>	$\overline{\text{CE}}$ LOW to Write End	7		8		10		ns
t <sub>AW</sub>	Address Setup to Write End	7		8		10		ns
t <sub>HA</sub>	Address Hold from Write End	0		0		0		ns
t <sub>SA</sub>	Address Setup to Write Start	0		0		0		ns
t <sub>PWE</sub>	$\overline{\text{WE}}$ Pulse Width	7		8		10		ns
t <sub>SD</sub>	Data Set-up to Write End	5		6		7		ns
t <sub>HD</sub>	Data Hold from Write End	0		0		0		ns
t <sub>LZWE</sub>	$\overline{\text{WE}}$ HIGH to Low-Z <sup>[8]</sup>	3		3		3		ns
t <sub>HZWE</sub>	$\overline{\text{WE}}$ LOW to High-Z <sup>[7, 8]</sup>		5		6		7	ns

### Notes

5. Test conditions assume signal transition time of 3 ns or less, timing reference levels of 1.5V, input pulse levels of 0 to 3.0V.
6.  $t_{\text{POWER}}$  gives the minimum amount of time that the power supply should be at stable, typical  $V_{\text{CC}}$  values until the first memory access can be performed.
7.  $t_{\text{HZOE}}$ ,  $t_{\text{HZCE}}$ , and  $t_{\text{HZWE}}$  are specified with a load capacitance of 5 pF as in part (d) of AC Test Loads. Transition is measured  $\pm 500$  mV from steady-state voltage.
8. At any given temperature and voltage condition,  $t_{\text{HZCE}}$  is less than  $t_{\text{LZCE}}$ ,  $t_{\text{HZOE}}$  is less than  $t_{\text{LZOE}}$ , and  $t_{\text{HZWE}}$  is less than  $t_{\text{LZWE}}$  for any given device.
9. The internal Write time of the memory is defined by the overlap of  $\overline{\text{CE}}$  LOW, and  $\overline{\text{WE}}$  LOW.  $\overline{\text{CE}}$  and  $\overline{\text{WE}}$  must be LOW to initiate a Write, and the transition of either of these signals can terminate the Write. The input data set-up and hold timing should be referenced to the leading edge of the signal that terminates the Write.
10. The minimum Write cycle time for Write Cycle No. 3 (WE controlled, OE LOW) is the sum of  $t_{\text{HZWE}}$  and  $t_{\text{SD}}$ .

## Switching Waveforms

Figure 4. Read Cycle No. 1 (Address Transition Controlled) [11, 12]

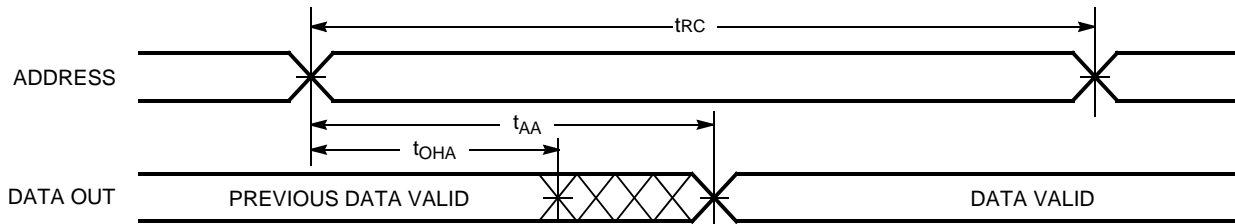


Figure 5. Read Cycle No. 2 ( $\overline{\text{OE}}$  Controlled) [12, 13]

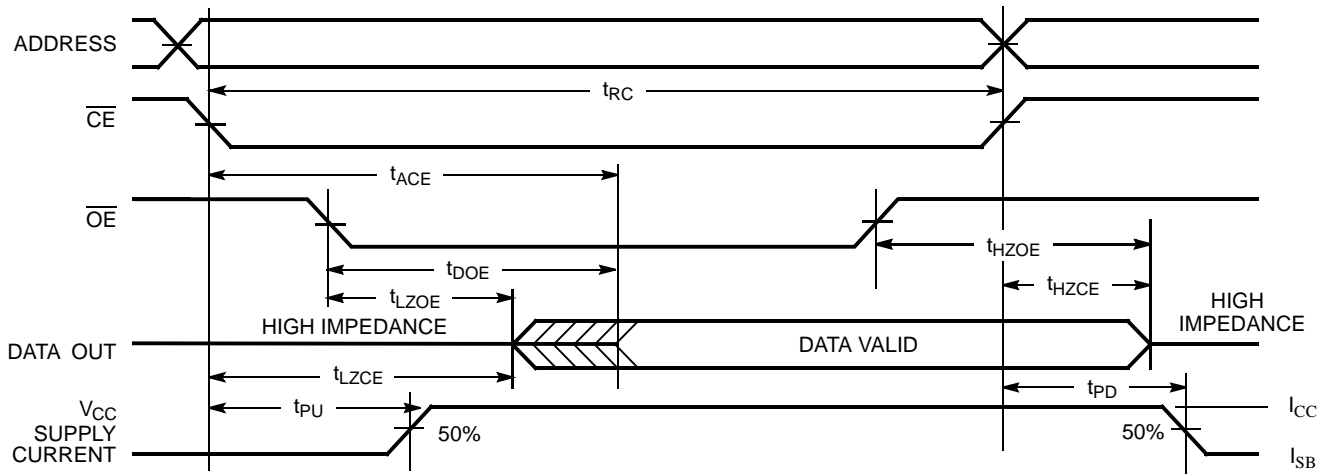
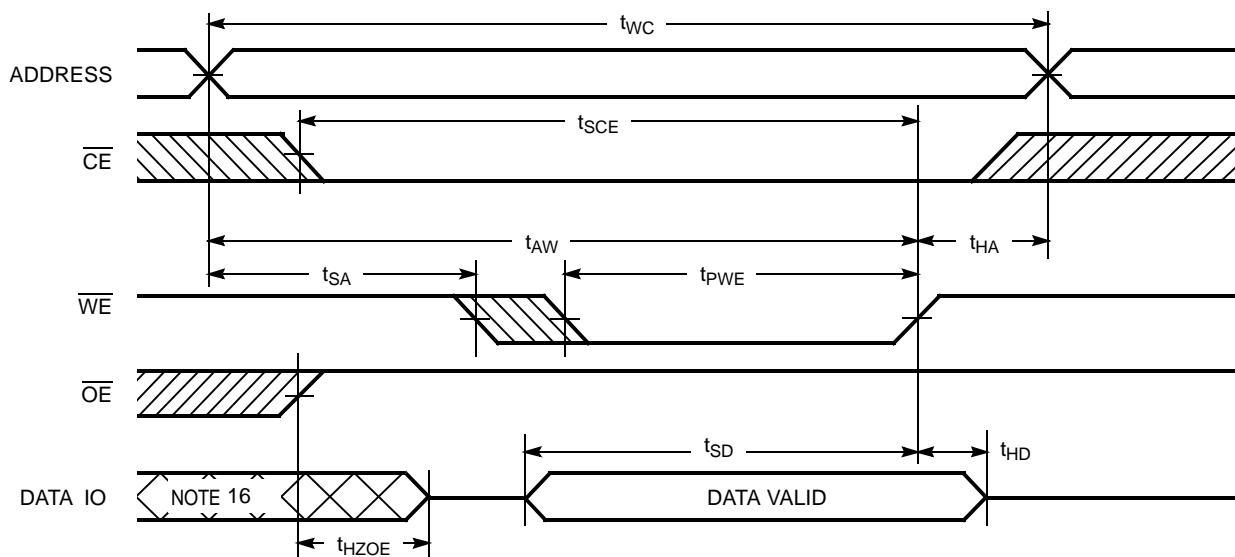


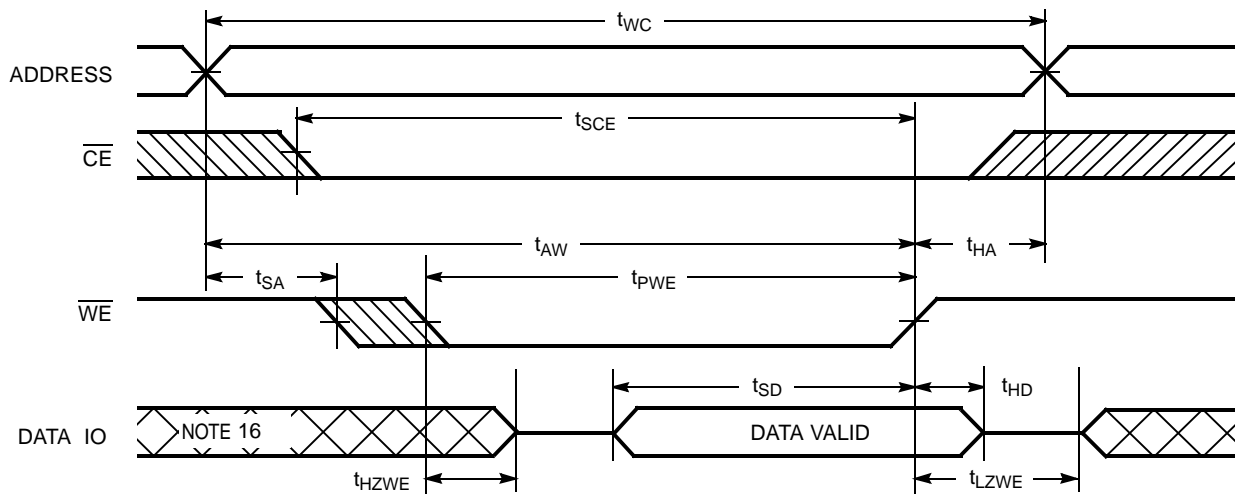
Figure 6. Write Cycle No. 1 ( $\overline{\text{WE}}$  Controlled,  $\overline{\text{OE}}$  HIGH During Write) [14, 15]



### Notes

11. Device is continuously selected.  $\overline{\text{OE}}, \overline{\text{CE}} = V_{IL}$ .
12.  $\overline{\text{WE}}$  is HIGH for read cycles.
13. Address valid before or similar to  $\overline{\text{CE}}$  transition LOW.
14. Data IO is high impedance if  $\overline{\text{OE}} = V_{IH}$ .
15. If  $\overline{\text{CE}}$  goes HIGH simultaneously with  $\overline{\text{WE}}$  HIGH, the output remains in high impedance state.
16. During this period, the IOs are in output state. Do not apply input signals.

**Switching Waveforms** (continued)

**Figure 7. Write Cycle No. 2 ( $\overline{\text{WE}}$  Controlled,  $\overline{\text{OE}}$  LOW) [15]**

**Truth Table**

$\overline{\text{CE}}$	$\overline{\text{OE}}$	$\overline{\text{WE}}$	I/O <sub>0</sub> -I/O <sub>7</sub>	Mode	Power
H	X	X	High-Z	Power Down	Standby ( $I_{\text{SB}}$ )
L	L	H	Data Out	Read	Active ( $I_{\text{CC}}$ )
L	X	L	Data In	Write	Active ( $I_{\text{CC}}$ )
L	H	H	High-Z	Selected, Outputs Disabled	Active ( $I_{\text{CC}}$ )

**Ordering Information**

Speed (ns)	Ordering Code	Package Diagram	Package Type	Operating Range
10	CY7C1049CV33-10VXC	51-85090	36-Pin (400-Mil) Molded SOJ (Pb-Free)	Commercial
	CY7C1049CV33-10ZXI	51-85087	44-Pin TSOP II (Pb-Free)	Industrial
12	CY7C1049CV33-12VXC	51-85090	36-Pin (400-Mil) Molded SOJ (Pb-Free)	Commercial
	CY7C1049CV33-12ZSXA	51-85087	44-Pin TSOP II (Pb-Free)	Automotive-A
15	CY7C1049CV33-15VXE	51-85090	36-Pin (400-Mil) Molded SOJ (Pb-Free)	Automotive-E
	CY7C1049CV33-15ZSXE	51-85087	44-Pin TSOP II (Pb-Free)	



## Package Diagrams

Figure 8. 36-Pin (400-Mil) Molded SOJ V36, 51-85090

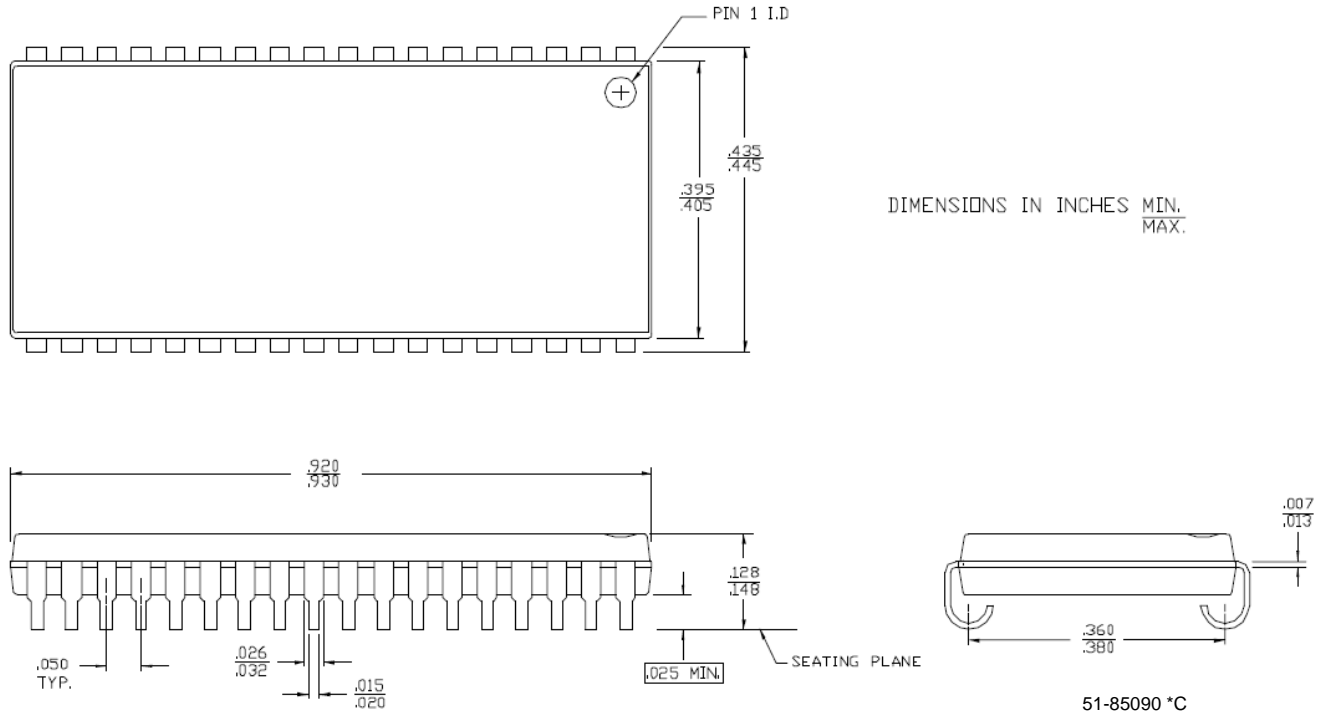
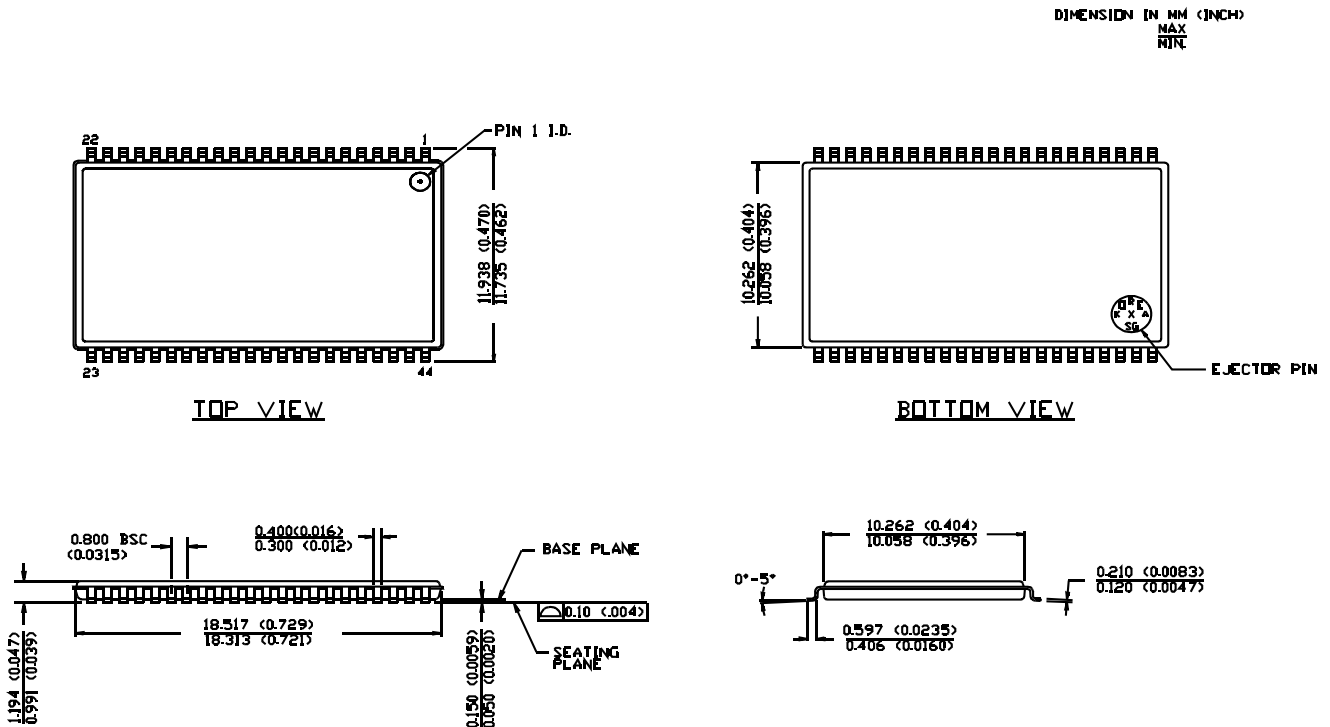


Figure 9. 44-Pin TSOP II, 51-85087



## Document History Page

Document Title: CY7C1049CV33, 4 Mbit (512K x 8) Static RAM Document Number: 38-05006				
Rev.	ECN	Orig. of Change	Submission Date	Description of Change
**	112569	HGK	03/06/02	New data sheet
*A	114091	DFP	04/25/02	Changed Tpower unit from ns to $\mu$ s
*B	116479	CEA	09/16/02	Add applications foot note to data sheet, page 1.
*C	262949	RKF	See ECN	Added Automotive-E Specs Added $\Theta_{JA}$ and $\Theta_{JC}$ values on Page #3.
*D	300091	RKF	See ECN	Added -20-ns Speed bin
*E	344595	SYT	See ECN	Added Pb-Free package on page #8 Removed shading for CY7C1049CV33-15ZSXE in the ordering Information on page 9
*F	2615344	VKN/PYRS	12/03/08	Added Automotive-A information Removed 8 ns and 20 ns speed bins, Changed $t_{POWER}$ spec from 1 $\mu$ s to 100 $\mu$ s, Updated Ordering Information table.

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